

Search Notes

Application/Control No.

10/657,054

Examiner

Paul D. Kim

Applicant(s)/Patent under
Reexamination

PLESKACH ET AL.

Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	602.1 604-606	6/15/2005	PK
336	176 200 229	6/15/2005	PK
156	89.11 89.12	6/15/2005	PK
	250		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search EAST/NPL (IEEE)	6/16/2005	PK